MOSFET – Power, N-Channel, Logic Level 100 V, 23 A, 56 mΩ

Features

- Low R_{DS(on)}
- 100% Avalanche Tested
- NVD Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V _{DSS}	100	V
Gate-to-Source Voltage - Continuous			V _{GS}	±20	V
Continuous Drain	$ \begin{array}{c c} \text{Steady} & T_{\text{C}} = 25^{\circ}\text{C} \\ \hline T_{\text{C}} = 100^{\circ}\text{C} \\ \end{array} $	I _D	23	Α	
Current		T _C = 100°C		16	
Power Dissipation	Steady State	T _C = 25°C	P _D	83	W
Pulsed Drain Current	t _p = 10 μs		I _{DM}	80	Α
Operating and Storage Temperature Range			T _J , T _{stg}	-55 to +175	°C
Source Current (Body Diode)			I _S	23	Α
Single Pulse Drain-to–Source Avalanche Energy (V_{DD} = 50 Vdc, V_{GS} = 10 Vdc, $I_{L(pk)}$ = 23 A, L = 0.3 mH, R_G = 25 Ω)			E _{AS}	79	mJ
Lead Temperature for Soldering Purposes, 1/8" from Case for 10 Seconds			TL	260	°C

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Case (Drain) - Steady State	$R_{\theta JC}$	1.8	°C/W
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	39	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

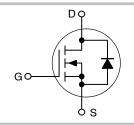
1. Surface mounted on FR4 board using 1 sq in pad size, (Cu Area 1.127 sq in [2 oz] including traces).



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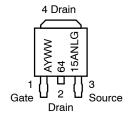
www.onsemi.com

V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX
100 V	56 mΩ @ 4.5 V	23 A
	52 mΩ @ 10 V	20 A





MARKING DIAGRAM & PIN ASSIGNMENT



A = Assembly Location*

6415ANL = Device Code

Y = Year WW = Work Week G = Pb-Free Package

* The Assembly Location code (A) is front side optional. In cases where the Assembly Location is stamped in the package, the front side assembly code may be blank.

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 2 of this data sheet.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	-		<u>'</u>		-	-	-
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V, } I_D = 250 \mu\text{A}$ $V_{GS} = 0 \text{ V, } I_D = 250 \mu\text{A, } T_J = -40 ^{\circ}\text{C}$		100 92			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	$V_{(BR)DSS}/T_J$				115		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 100 V	$T_{J} = 25^{\circ}C$ $T_{J} = 125^{\circ}C$			1.0 100	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} =	± 20 V			±100	nA
ON CHARACTERISTICS (Note 2)	ı		l				
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$, $I_D =$	250 μΑ	1.0		2.0	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				4.8		mV/°C
Drain-to-Source On-Resistance	R _{DS(on)}	V _{GS} = 4.5 V, I _D	= 10 A		44	56	mΩ
		V _{GS} = 10 V, I _D	= 10 A		43	52	
Forward Transconductance	9FS	V _{DS} = 5.0 V, I _D = 10 A			24		S
CHARGES, CAPACITANCES AND GA	TE RESISTANO	CE					
Input Capacitance	C _{ISS}				1024		pF
Output Capacitance	C _{OSS}	V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = 25 V			156		
Reverse Transfer Capacitance	C _{RSS}				70		
Total Gate Charge	Q _{G(TOT)}				20		nC
Threshold Gate Charge	Q _{G(TH)}				1.1		
Gate-to-Source Charge	Q_{GS}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 80$) V, I _D = 23 A		3.1		
Gate-to-Drain Charge	Q_{GD}	1			14		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 80 V, I _D = 23 A			35		nC
SWITCHING CHARACTERISTICS (Not	e 3)						
Turn-On Delay Time	t _{d(on)}				11		ns
Rise Time	t _r	V _{GS} = 4.5 V, V _{DE}	₀ = 80 V,		91		
Turn-Off Delay Time	t _{d(off)}	$I_D = 23 \text{ A}, R_G =$	6.1 Ω		40		
Fall Time	t _f				71		
DRAIN-SOURCE DIODE CHARACTER	RISTICS						
Forward Diode Voltage	V_{SD}	V _{GS} = 0 V, I _S = 23 A	$T_{J} = 25^{\circ}C$ $T_{J} = 125^{\circ}C$		0.87 0.74	1.2	٧
Reverse Recovery Time	tes		17 - 123 0		64		ns
Charge Time	t _{RR}	$V_{GS} = 0 \text{ V, } dI_S/dt = 100 \text{ A/}\mu\text{s,}$ $I_S = 23 \text{ A}$			40		_ 113
Discharge Time					24		
	T _b						r.C
Reverse Recovery Charge	Q_{RR}				152		nC

^{2.} Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2%.

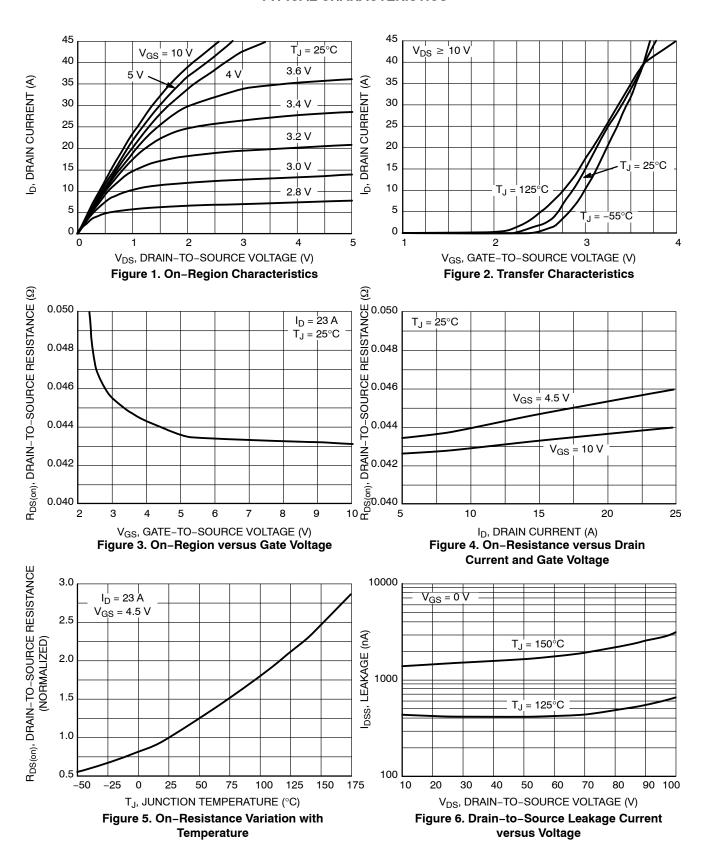
ORDERING INFORMATION

Device	Package	Shipping [†]		
NTD6415ANLT4G				
NVD6415ANLT4G	DPAK (Pb-Free)	2500 / Tape & Reel		
NVD6415ANLT4G-VF01	,			

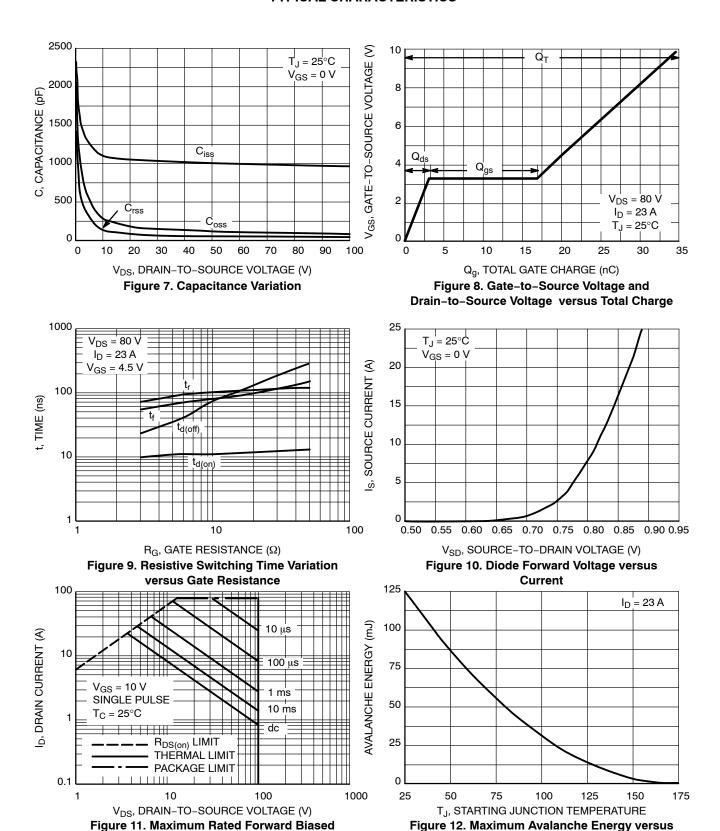
[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

^{3.} Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



Starting Junction Temperature

Safe Operating Area

TYPICAL CHARACTERISTICS

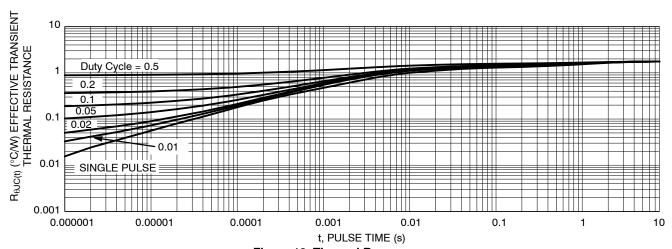
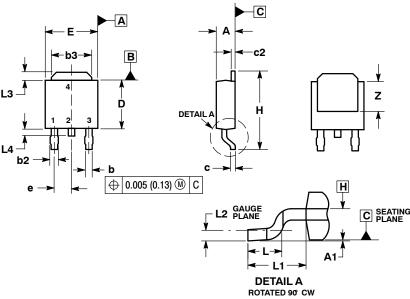


Figure 13. Thermal Response

PACKAGE DIMENSIONS

DPAK (SINGLE GUAGE)

CASE 369AA **ISSUE B**



NOTES

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 2. CONTROLLING DIMENSION: INCHES.
- THERMAL PAD CONTOUR OPTIONAL WITHIN DI-MENSIONS b3, L3 and Z.
- DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL
- NOT EXCEED 0.006 INCHES PER SIDE.
 5. DIMENSIONS D AND E ARE DETERMINED AT THE
- OUTERMOST EXTREMES OF THE PLASTIC BODY.
 6. DATUMS A AND B ARE DETERMINED AT DATUM

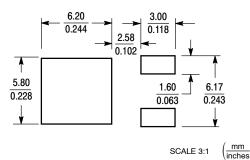
	INCHES		MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.086	0.094	2.18	2.38	
A1	0.000	0.005	0.00	0.13	
b	0.025	0.035	0.63	0.89	
b2	0.030	0.045	0.76	1.14	
b3	0.180	0.215	4.57	5.46	
С	0.018	0.024	0.46	0.61	
c2	0.018	0.024	0.46	0.61	
D	0.235	0.245	5.97	6.22	
E	0.250	0.265	6.35	6.73	
е	0.090	BSC	2.29 BSC		
Н	0.370	0.410	9.40	10.41	
L	0.055	0.070	1.40	1.78	
L1	0.108 REF		2.74	REF	
L2	0.020 BSC		0.51).51 BSC	
L3	0.035	0.050	0.89	1.27	
L4		0.040		1.01	
Z	0.155		3.93		

STYLE 2:

PIN 1. GATE

- 2. DRAIN 3. SOURCE
- DRAIN

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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